## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under | Reexamination | BIEDA ET AL. | Examiner | Art Unit | Xiuqin Sun | 2863 | Page 1 of 1

## U.S. PATENT DOCUMENTS

	O.G. FAILTY BOOGNETTO						
.*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification		
	Α	US-6,319,737	11-2001	Putnam et al.	438/17		
	В	US-					
	ပ	US-					
	D	US-					
	E	US-					
	F	US-					
	G	US-					
	Н	US-					
	_	US-					
	J	US-					
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	L	US-					
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## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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